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Supporting Information for

## Scrutinizing the important roles of hole transport layers in near-intrinsic $\text{Sb}_2\text{S}_3$ planar solar cells

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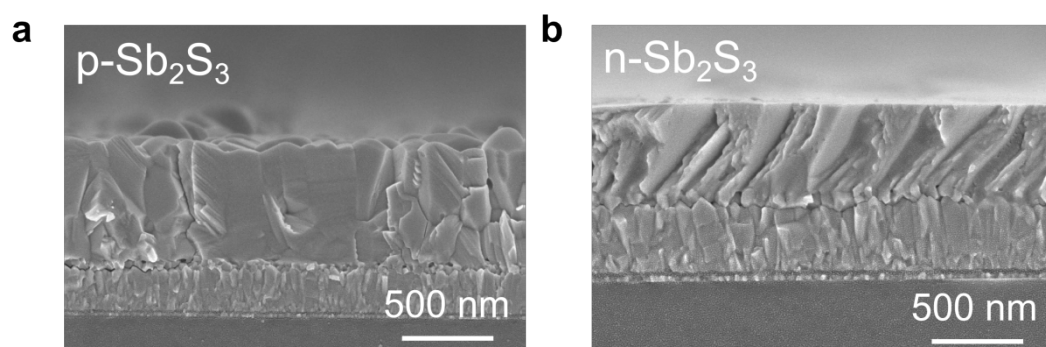
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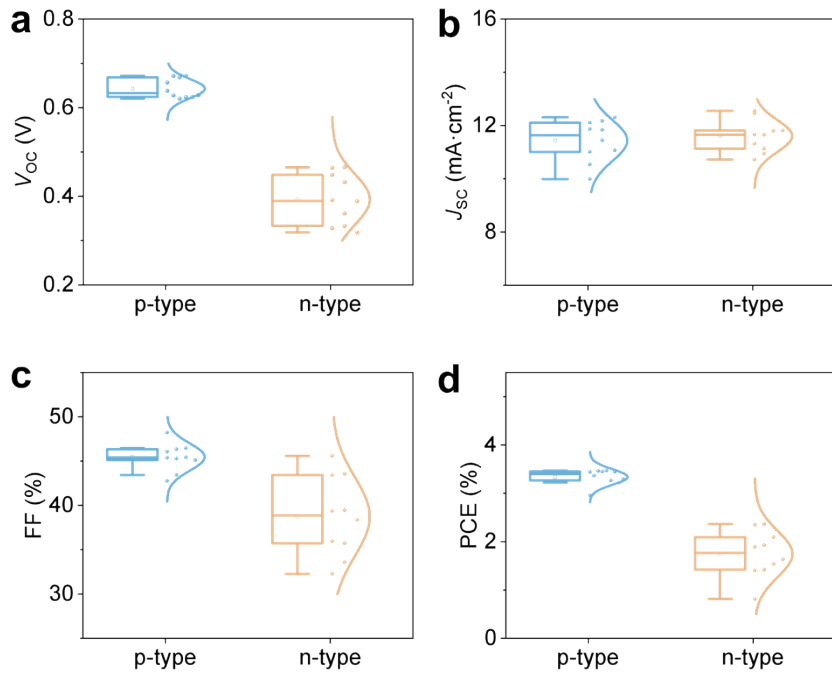
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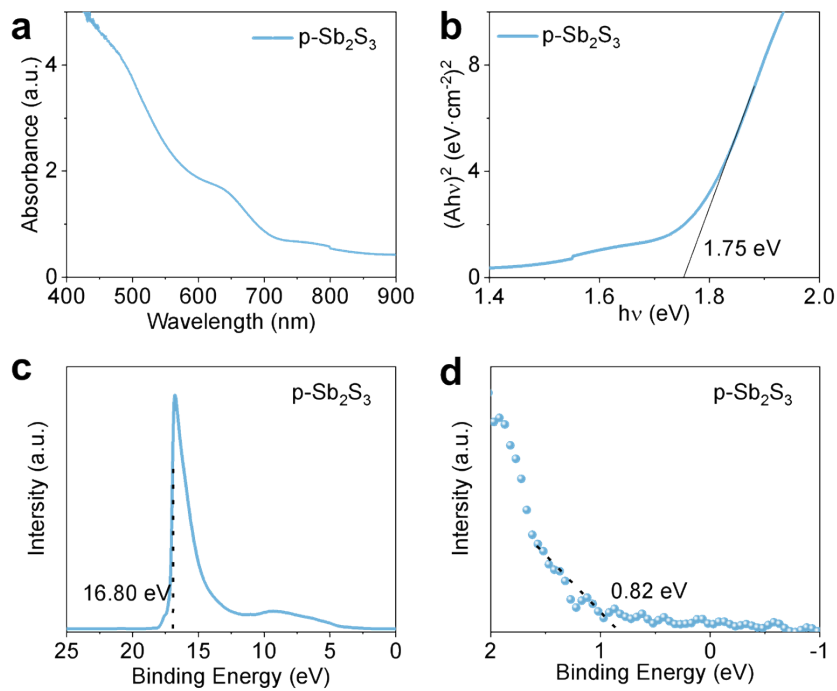
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**Fig. S1.** (Color online) Cross-sectional-view SEM images of (a) p-type and (b) n-type  $\text{Sb}_2\text{S}_3$  thin films.



**Fig. S2.** (Color online) Statistics of performance parameters of FTO/CdS/p-Sb<sub>2</sub>S<sub>3</sub>/Au and FTO/CdS/n-Sb<sub>2</sub>S<sub>3</sub>/Au solar cells: (a)  $V_{OC}$ , (b)  $J_{SC}$ , (c) FF, (d) PCE.



**Fig. S3.** (Color online) (a)-(b) Absorption spectrum and Tauc plots for p-Sb<sub>2</sub>S<sub>3</sub> films. UPS spectrum of p-Sb<sub>2</sub>S<sub>3</sub> near (c) the secondary electron cutoff edge and (d) the Fermi edge.

**Table S1.** Photovoltaic performance parameters of FTO/CdS/Sb<sub>2</sub>S<sub>3</sub>/Au and FTO/CdS/Sb<sub>2</sub>S<sub>3</sub>/Spiro-MeTAD/Au based on SCAPS simulations.

Device	$V_{OC}$ (V)	$J_{SC}$ (mA·cm <sup>-2</sup> )	FF (%)	PCE (%)
FTO/CdS/p-Sb <sub>2</sub> S <sub>3</sub> /Au	1.02	19.62	68.69	13.78
FTO/CdS/p-Sb <sub>2</sub> S <sub>3</sub> /Spiro-OMeTAD/Au	1.09	19.72	78.85	16.89
FTO/CdS/n-Sb <sub>2</sub> S <sub>3</sub> /Au	0.82	18.75	83.48	12.84
FTO/CdS/n-Sb <sub>2</sub> S <sub>3</sub> /Spiro-OMeTAD/Au	1.29	18.84	84.79	20.66

**Table S2.** Basic material parameters of different HTLs

Parameter	Cu <sub>2</sub> O	CuSCN	CuI	Spiro-OMeTAD
Thickness (nm)	200	200	200	200
Dielectric permittivity	7.11	10	6.5	3
Bandgap, $E_g$ (eV)	2.17	3.6	2.98	3.17
Electron affinity, $\chi$ (eV)	3.2	1.7	2.1	2.05
Electron mobility (cm <sup>2</sup> ·V <sup>-1</sup> ·s <sup>-1</sup> )	200	100	$1.7 \times 10^{-4}$	$2 \times 10^{-4}$
Hole mobility (cm <sup>2</sup> ·V <sup>-1</sup> ·s <sup>-1</sup> )	80	25	$2 \times 10^{-4}$	$2 \times 10^{-4}$
CB effective density of states (cm <sup>-3</sup> )	$2.02 \times 10^{17}$	$2.2 \times 10^{19}$	$2.8 \times 10^{19}$	$2.2 \times 10^{18}$
VB effective density of states (cm <sup>-3</sup> )	$1.1 \times 10^{19}$	$1.8 \times 10^{19}$	$10^{19}$	$1.8 \times 10^{19}$
Acceptor doping concentration (cm <sup>-3</sup> )	$2 \times 10^{19}$	$2 \times 10^{19}$	$2 \times 10^{19}$	$2 \times 10^{19}$
Donor doping concentration (cm <sup>-3</sup> )	-	-	-	-
Electron/hole thermal velocity (cm <sup>-3</sup> )	$10^7$	$10^7$	$10^7$	$10^7$
Defect density (cm <sup>-3</sup> )	$10^{15}$	$10^{15}$	$10^{15}$	$10^{15}$